

## **C3M0280090D**

### **Silicon Carbide Power MOSFET**

### **C3M™ MOSFET Technology**

### **N-Channel Enhancement Mode**

#### **Features**

- New C3M SiC MOSFET technology
- High blocking voltage with low On-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant

#### **Benefits**

- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency

#### **Applications**

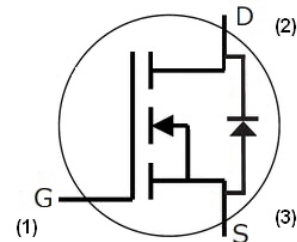
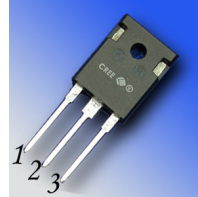
- Renewable energy
- Lighting
- High voltage DC/DC converters
- Telecom Power Supplies
- Induction Heating

$$V_{DS} = 900 \text{ V}$$

$$I_D @ 25^\circ\text{C} = 11.5 \text{ A}$$

$$R_{DS(on)} = 280 \text{ m}\Omega$$

#### **Package**



| Part Number | Package  |
|-------------|----------|
| C3M0280090D | TO-247-3 |

#### **Maximum Ratings** ( $T_C = 25^\circ\text{C}$ unless otherwise specified)

| Symbol         | Parameter                                  | Value       | Unit             | Test Conditions                                   | Note    |
|----------------|--------------------------------------------|-------------|------------------|---------------------------------------------------|---------|
| $V_{DSmax}$    | Drain - Source Voltage                     | 900         | V                | $V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$     |         |
| $V_{GSmax}$    | Gate - Source Voltage                      | -8/+18      | V                | Absolute maximum values                           |         |
| $V_{GSop}$     | Gate - Source Voltage                      | -4/+15      | V                | Recommended operational values                    | Note 1  |
| $I_D$          | Continuous Drain Current                   | 11.5        | A                | $V_{GS} = 15 \text{ V}, T_C = 25^\circ\text{C}$   | Fig. 19 |
|                |                                            | 7.5         |                  | $V_{GS} = 15 \text{ V}, T_C = 100^\circ\text{C}$  |         |
| $I_{D(pulse)}$ | Pulsed Drain Current                       | 22          | A                | Pulse width $t_p$ limited by $T_{jmax}$           | Fig. 22 |
| $P_D$          | Power Dissipation                          | 54          | W                | $T_C = 25^\circ\text{C}, T_J = 150^\circ\text{C}$ | Fig. 20 |
| $T_J, T_{stg}$ | Operating Junction and Storage Temperature | -55 to +150 | $^\circ\text{C}$ |                                                   |         |
| $T_L$          | Solder Temperature                         | 260         | $^\circ\text{C}$ | 1.6mm (0.063") from case for 10s                  |         |

Note (1): MOSFET can also safely operate at 0/+15 V

| Symbol        | Parameter                        | Min. | Typ. | Max. | Unit          | Test Conditions                                                                                                                                                         | Note                   |
|---------------|----------------------------------|------|------|------|---------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage   | 900  |      |      | V             | $V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$                                                                                                                     |                        |
| $V_{GS(th)}$  | Gate Threshold Voltage           | 1.8  | 2.1  | 3.5  | V             | $V_{DS} = V_{GS}, I_D = 1.2\text{ mA}$                                                                                                                                  | Fig. 11                |
|               |                                  |      | 1.6  |      | V             | $V_{DS} = V_{GS}, I_D = 1.2\text{ mA}, T_J = 150^\circ\text{C}$                                                                                                         |                        |
| $I_{DSS}$     | Zero Gate Voltage Drain Current  |      | 1    | 100  | $\mu\text{A}$ | $V_{DS} = 900\text{ V}, V_{GS} = 0\text{ V}$                                                                                                                            |                        |
| $I_{GSS}$     | Gate-Source Leakage Current      |      | 10   | 250  | nA            | $V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$                                                                                                                             |                        |
| $R_{DS(on)}$  | Drain-Source On-State Resistance |      | 280  | 360  | m $\Omega$    | $V_{GS} = 15\text{ V}, I_D = 7.5\text{ A}$                                                                                                                              | Fig. 4, 5, 6           |
|               |                                  |      | 385  |      |               | $V_{GS} = 15\text{ V}, I_D = 7.5\text{ A}, T_J = 150^\circ\text{C}$                                                                                                     |                        |
| $g_{fs}$      | Transconductance                 |      | 3.6  |      | S             | $V_{DS} = 15\text{ V}, I_{DS} = 7.5\text{ A}$                                                                                                                           | Fig. 7                 |
|               |                                  |      | 3.1  |      |               | $V_{DS} = 15\text{ V}, I_{DS} = 7.5\text{ A}, T_J = 150^\circ\text{C}$                                                                                                  |                        |
| $C_{iss}$     | Input Capacitance                |      | 150  |      | pF            | $V_{GS} = 0\text{ V}, V_{DS} = 600\text{ V}$<br>$f = 1\text{ MHz}$<br>$V_{AC} = 25\text{ mV}$                                                                           | Fig. 17, 18            |
| $C_{oss}$     | Output Capacitance               |      | 20   |      |               |                                                                                                                                                                         |                        |
| $C_{rss}$     | Reverse Transfer Capacitance     |      | 2    |      |               |                                                                                                                                                                         |                        |
| $E_{oss}$     | $C_{oss}$ Stored Energy          |      | 4.5  |      | $\mu\text{J}$ |                                                                                                                                                                         | Fig. 16                |
| $E_{ON}$      | Turn-On Switching Energy         |      | 57   |      | $\mu\text{J}$ | $V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}, I_D = 7.5\text{ A},$<br>$R_{G(ext)} = 2.5\text{ }\Omega, L = 220\text{ }\mu\text{H}, T_J = 150^\circ\text{C}$ | Fig. 26, 29<br>Note(3) |
| $E_{OFF}$     | Turn Off Switching Energy        |      | 6    |      |               |                                                                                                                                                                         |                        |
| $t_{d(on)}$   | Turn-On Delay Time               |      | 26   |      | ns            | $V_{DD} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$<br>$I_D = 7.5\text{ A}, R_{G(ext)} = 2.5\text{ }\Omega,$<br>Timing relative to $V_{DS}$<br>Inductive load     | Fig. 27, 29<br>Note(3) |
| $t_r$         | Rise Time                        |      | 10   |      |               |                                                                                                                                                                         |                        |
| $t_{d(off)}$  | Turn-Off Delay Time              |      | 17.5 |      |               |                                                                                                                                                                         |                        |
| $t_f$         | Fall Time                        |      | 7.5  |      |               |                                                                                                                                                                         |                        |
| $R_{G(int)}$  | Internal Gate Resistance         |      | 26   |      | $\Omega$      | $f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$                                                                                                                               |                        |
| $Q_{gs}$      | Gate to Source Charge            |      | 2.8  |      | nC            | $V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$<br>$I_D = 7.5\text{ A}$<br>Per IEC60747-8-4 pg 21                                                             | Fig. 12                |
| $Q_{gd}$      | Gate to Drain Charge             |      | 3.4  |      |               |                                                                                                                                                                         |                        |
| $Q_g$         | Total Gate Charge                |      | 9.5  |      |               |                                                                                                                                                                         |                        |

**Reverse Diode Characteristics** ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

| Symbol         | Parameter                        | Typ. | Max. | Unit | Test Conditions                                                                                                                               | Note          |
|----------------|----------------------------------|------|------|------|-----------------------------------------------------------------------------------------------------------------------------------------------|---------------|
| $V_{SD}$       | Diode Forward Voltage            | 4.8  |      | V    | $V_{GS} = -4\text{ V}, I_{SD} = 4\text{ A}$                                                                                                   | Fig. 8, 9, 10 |
|                |                                  | 4.4  |      | V    | $V_{GS} = -4\text{ V}, I_{SD} = 4\text{ A}, T_J = 150^\circ\text{C}$                                                                          |               |
| $I_S$          | Continuous Diode Forward Current |      | 16.5 | A    | $V_{GS} = -4\text{ V}$                                                                                                                        | Note 2        |
| $I_{S, pulse}$ | Diode pulse Current              |      | 22   | A    | $V_{GS} = -4\text{ V},$ pulse width $t_p$ limited by $T_{jmax}$                                                                               | Note 2        |
| $t_{rr}$       | Reverse Recover time             | 20   |      | ns   | $V_{GS} = -4\text{ V}, I_{SD} = 4\text{ A}, V_R = 400\text{ V}$<br>$\text{dif}/\text{dt} = 600\text{ A}/\mu\text{s}, T_J = 150^\circ\text{C}$ | Note 2        |
| $Q_{rr}$       | Reverse Recovery Charge          | 47   |      | nC   |                                                                                                                                               |               |
| $I_{rrm}$      | Peak Reverse Recovery Current    | 3.4  |      | A    |                                                                                                                                               |               |

Note (2): When using SiC Body Diode the maximum recommended  $V_{GS} = -4\text{ V}$

**Thermal Characteristics**

| Symbol          | Parameter                                   | Max. | Unit                      | Test Conditions | Note    |
|-----------------|---------------------------------------------|------|---------------------------|-----------------|---------|
| $R_{\theta JC}$ | Thermal Resistance from Junction to Case    | 2.3  | $^\circ\text{C}/\text{W}$ |                 | Fig. 21 |
| $R_{\theta JA}$ | Thermal Resistance From Junction to Ambient | 40   |                           |                 |         |

## Typical Performance

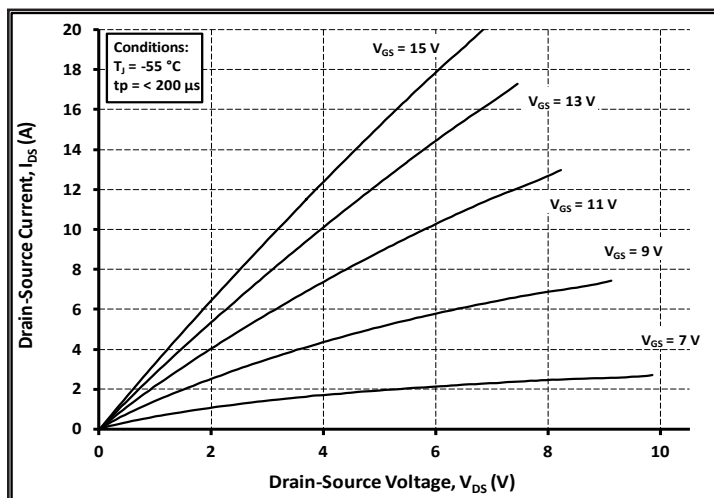


Figure 1. Output Characteristics  $T_J = -55\text{ }^{\circ}\text{C}$

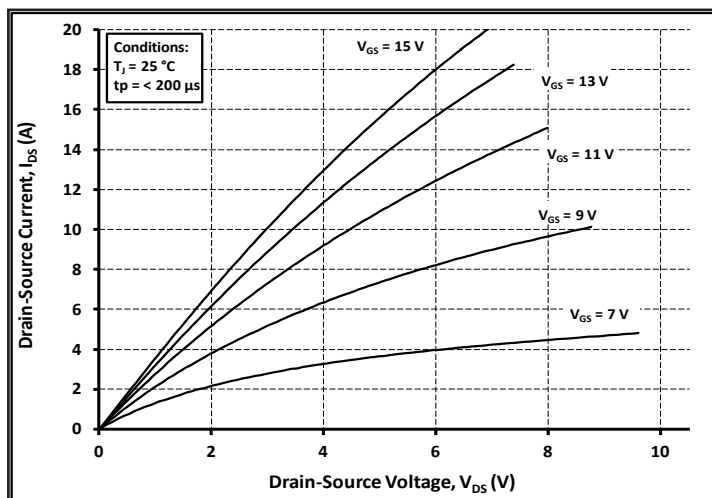


Figure 2. Output Characteristics  $T_J = 25\text{ }^{\circ}\text{C}$

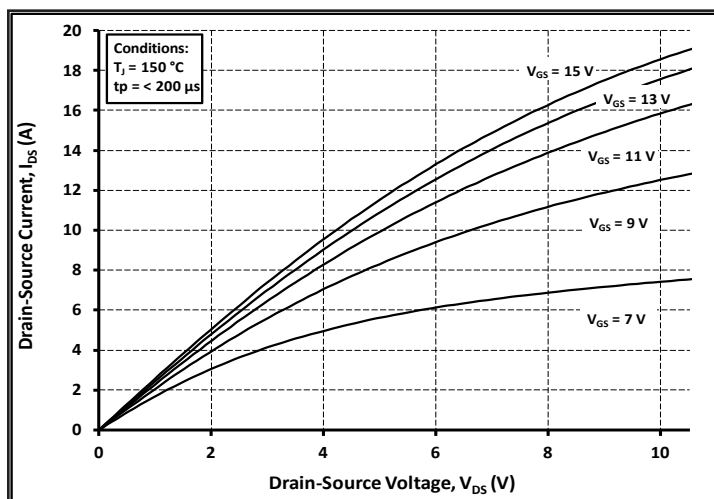


Figure 3. Output Characteristics  $T_J = 150\text{ }^{\circ}\text{C}$

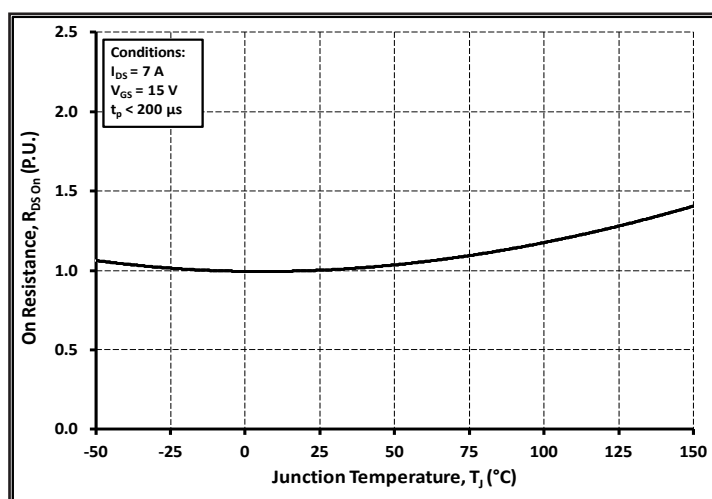


Figure 4. Normalized On-Resistance vs. Temperature

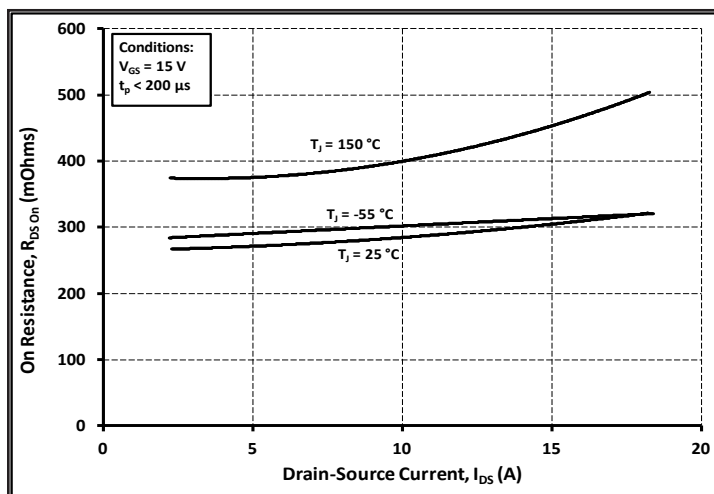


Figure 5. On-Resistance vs. Drain Current  
For Various Temperatures

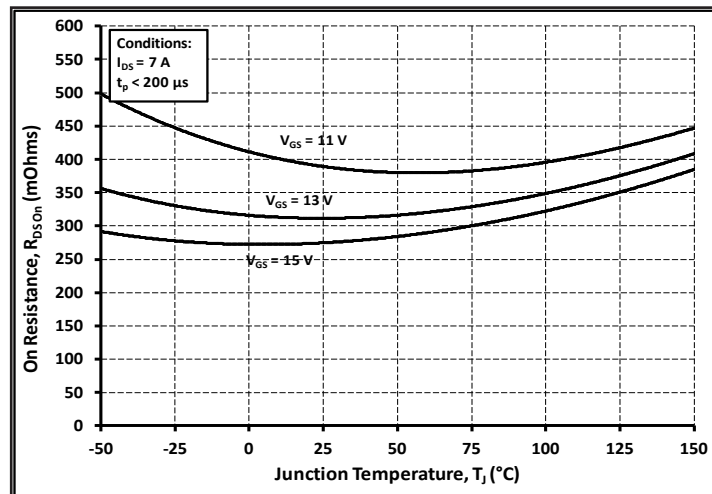


Figure 6. On-Resistance vs. Temperature  
For Various Gate Voltage

## Typical Performance

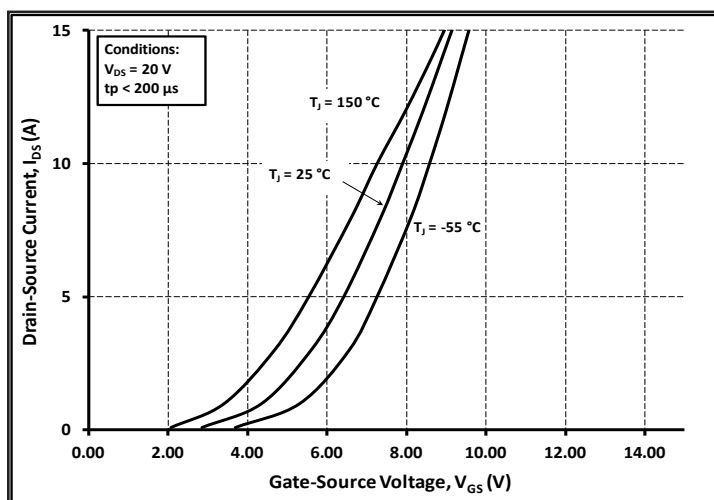


Figure 7. Transfer Characteristic for Various Junction Temperatures

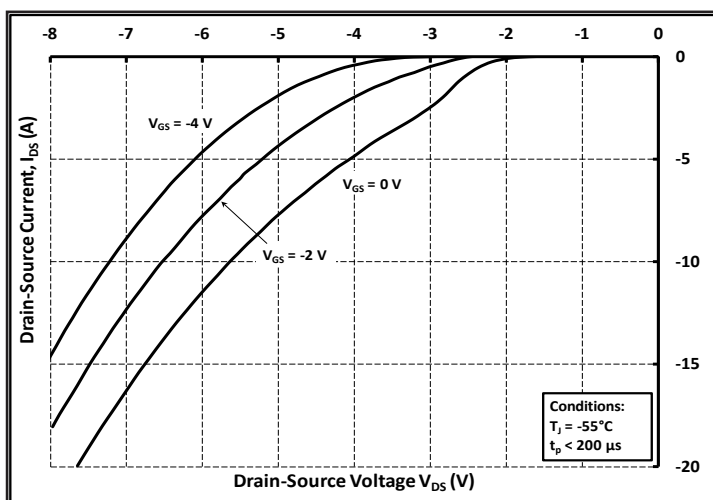


Figure 8. Body Diode Characteristic at -55 °C

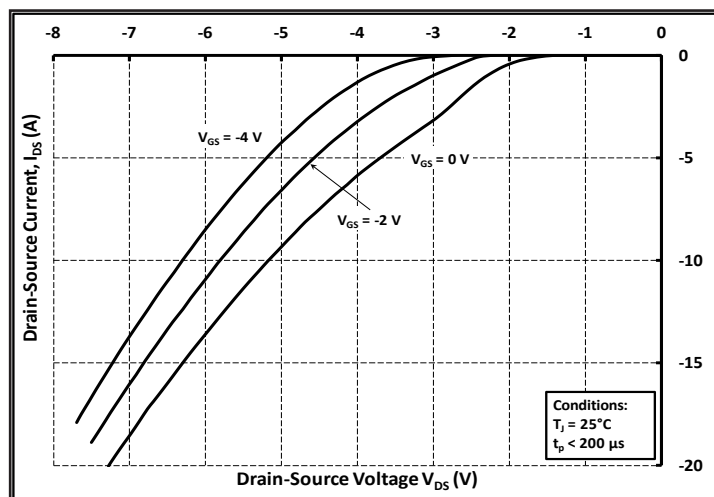


Figure 9. Body Diode Characteristic at 25 °C

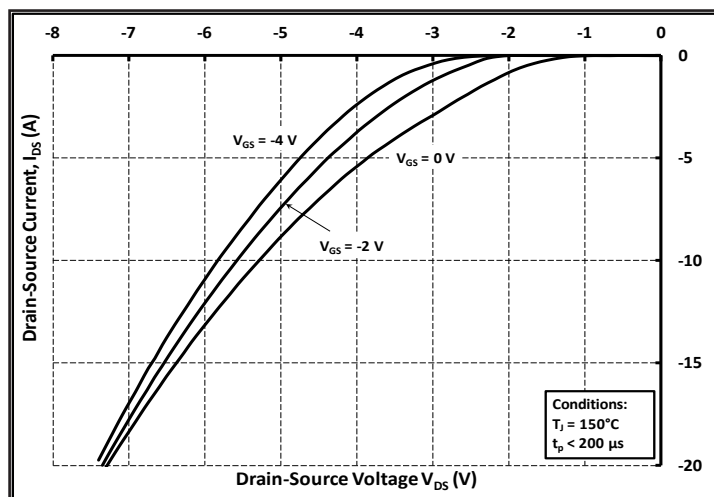


Figure 10. Body Diode Characteristic at 150 °C

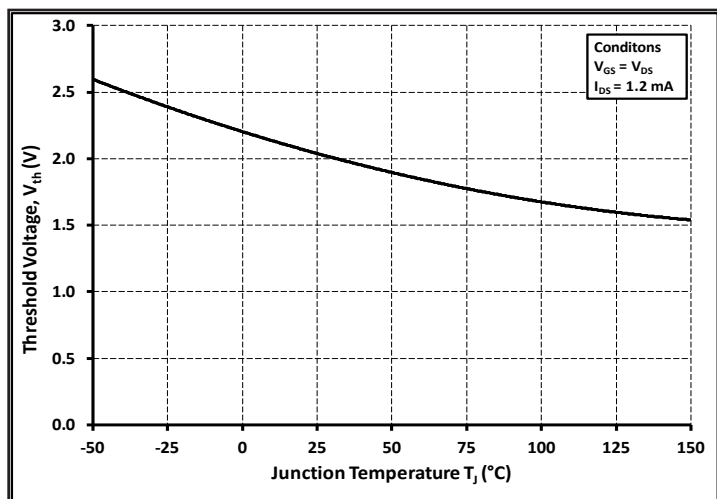


Figure 11. Threshold Voltage vs. Temperature

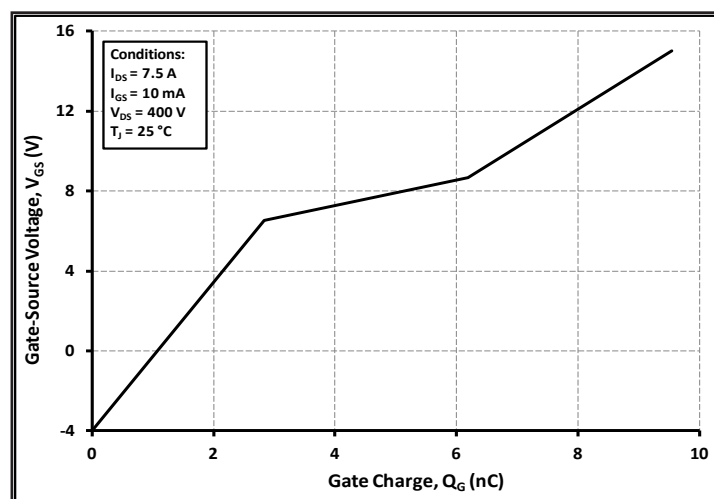


Figure 12. Gate Charge Characteristics

## Typical Performance

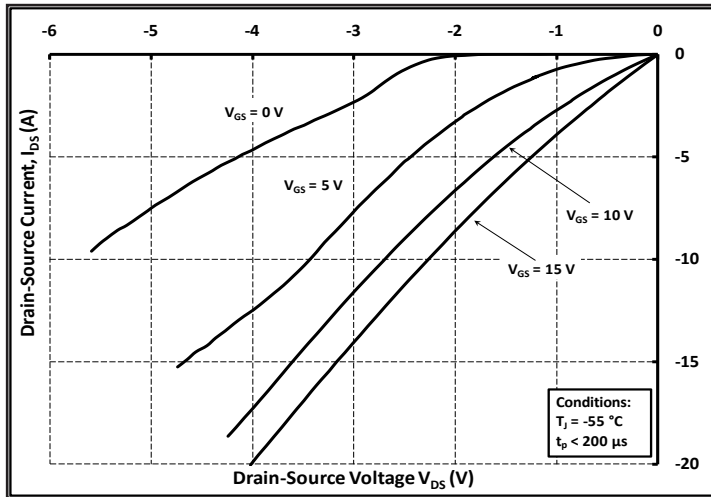


Figure 13. 3rd Quadrant Characteristic at  $-55\text{ }^{\circ}\text{C}$

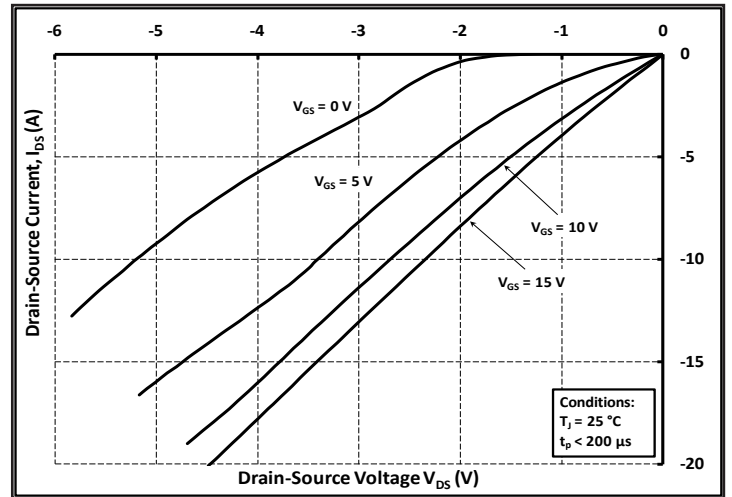


Figure 14. 3rd Quadrant Characteristic at  $25\text{ }^{\circ}\text{C}$

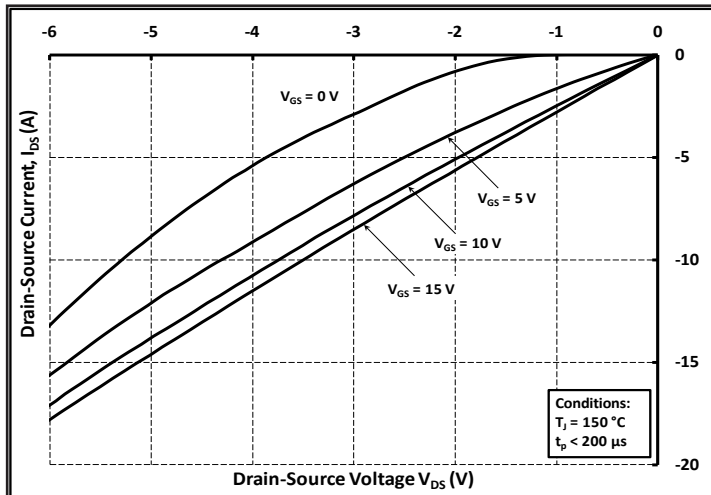


Figure 15. 3rd Quadrant Characteristic at  $150\text{ }^{\circ}\text{C}$

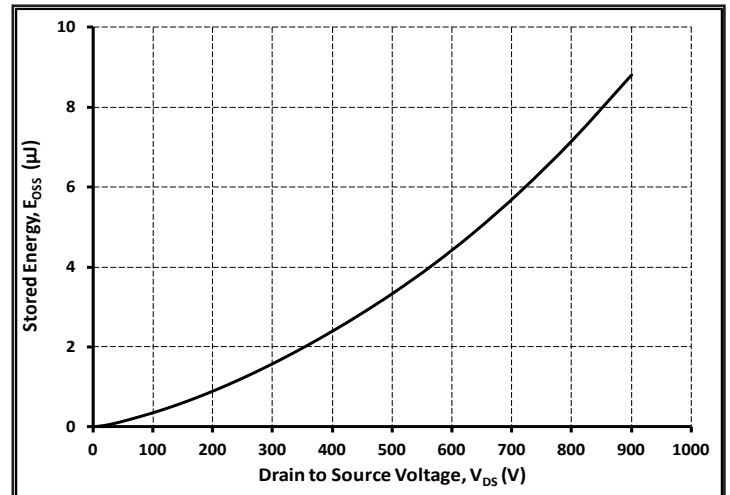


Figure 16. Output Capacitor Stored Energy

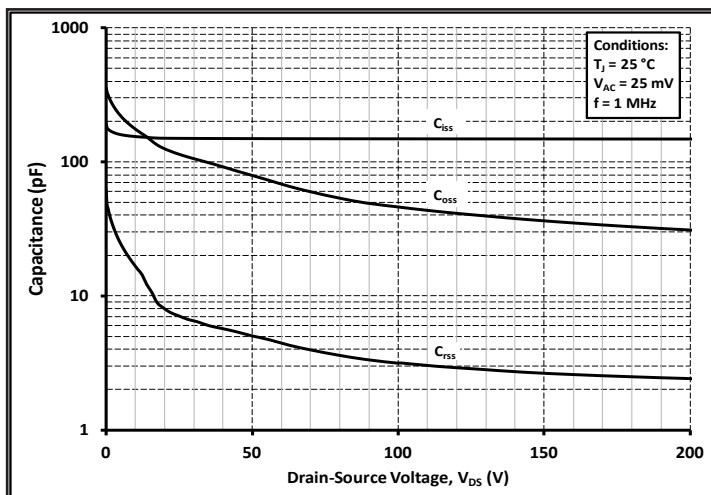


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

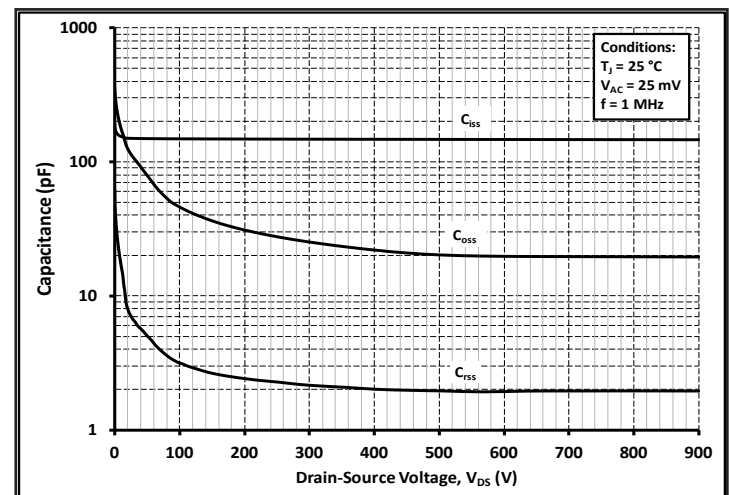


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 900V)

## Typical Performance

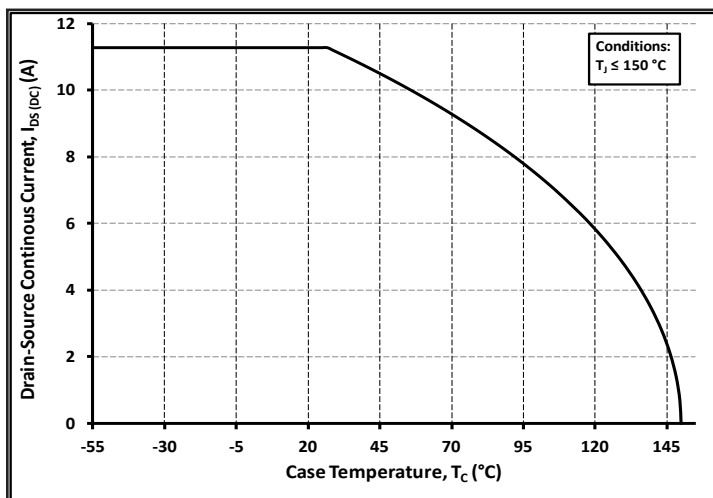


Figure 19. Continuous Drain Current Derating vs. Case Temperature

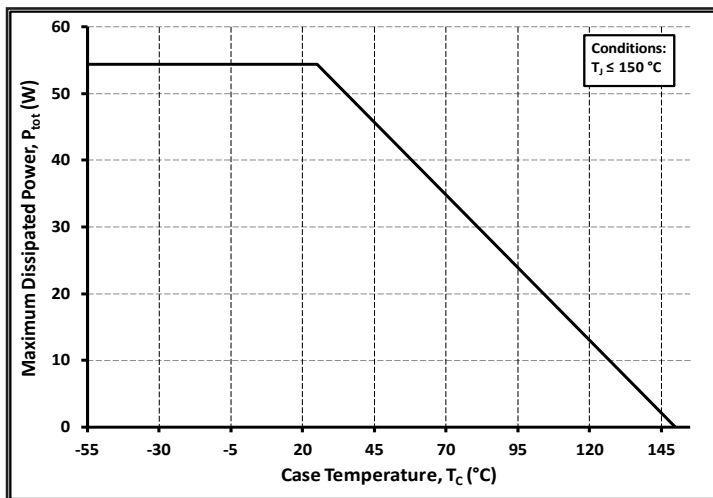


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

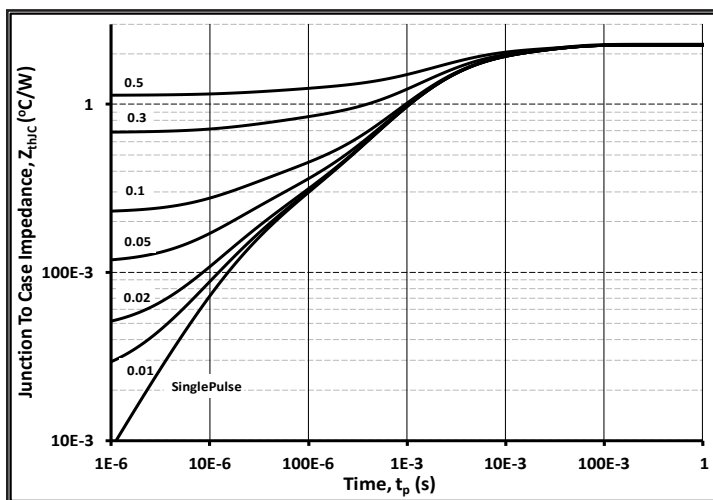


Figure 21. Transient Thermal Impedance (Junction - Case)

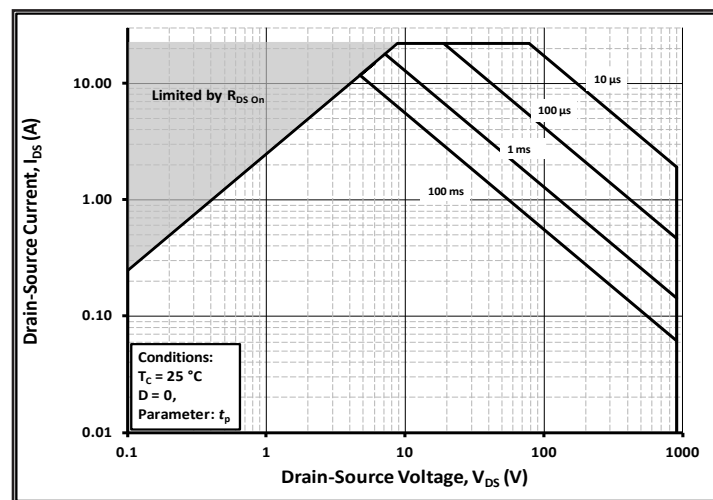


Figure 22. Safe Operating Area

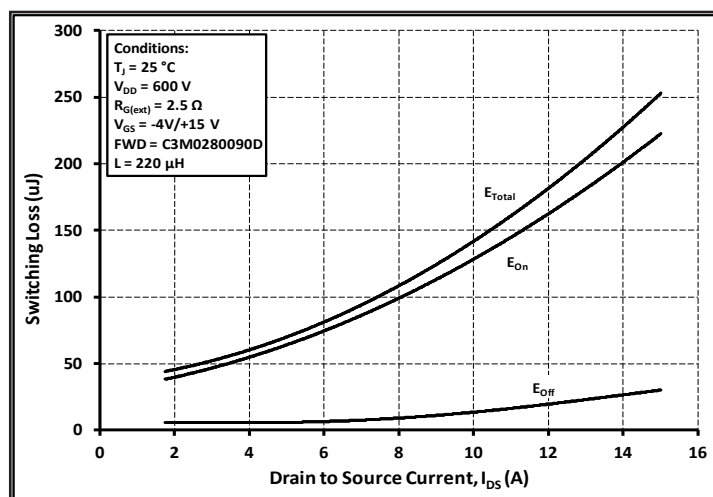


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 600V$ )

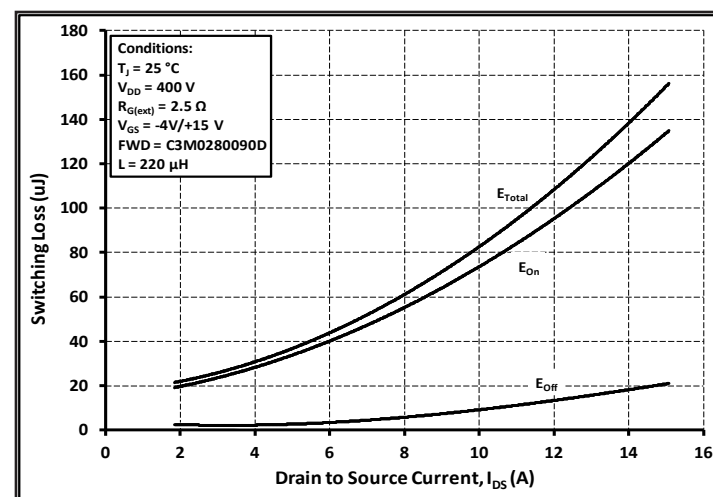


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 400V$ )

## Typical Performance

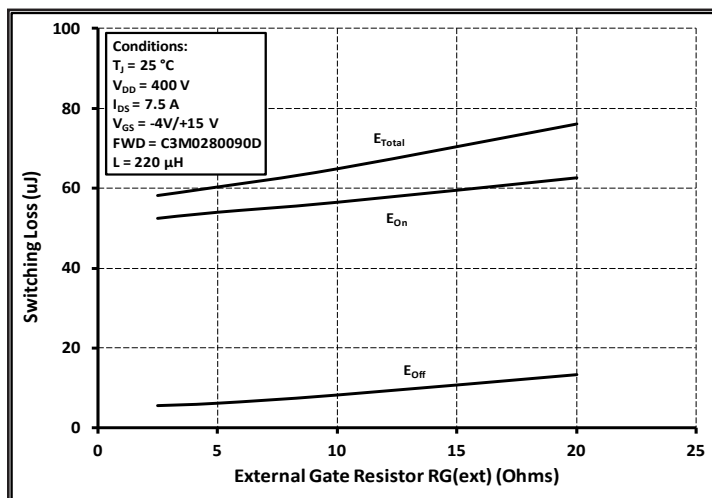


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

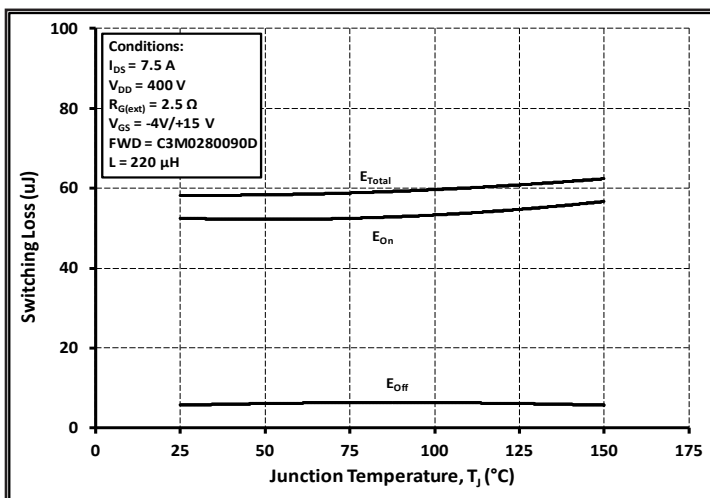


Figure 26. Clamped Inductive Switching Energy vs. Temperature

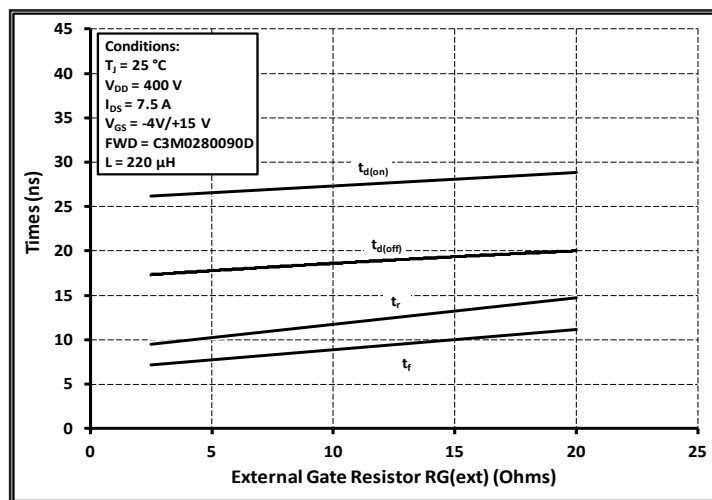


Figure 27. Switching Times vs.  $R_{G(ext)}$

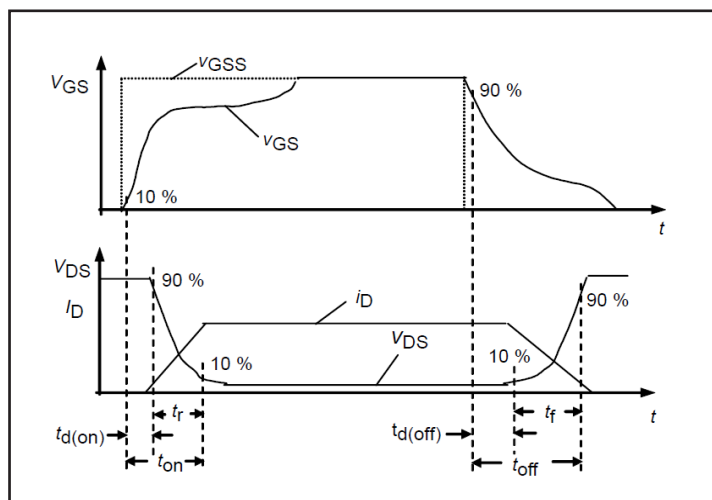


Figure 28. Switching Times Definition

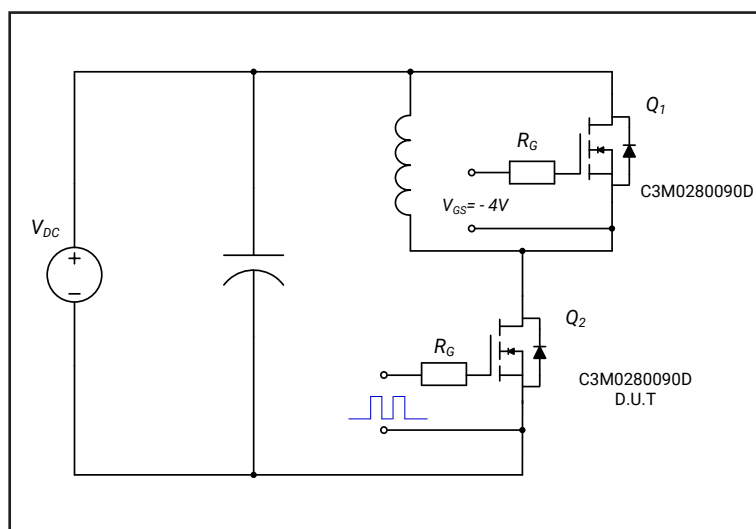
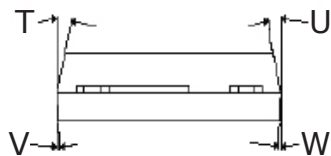
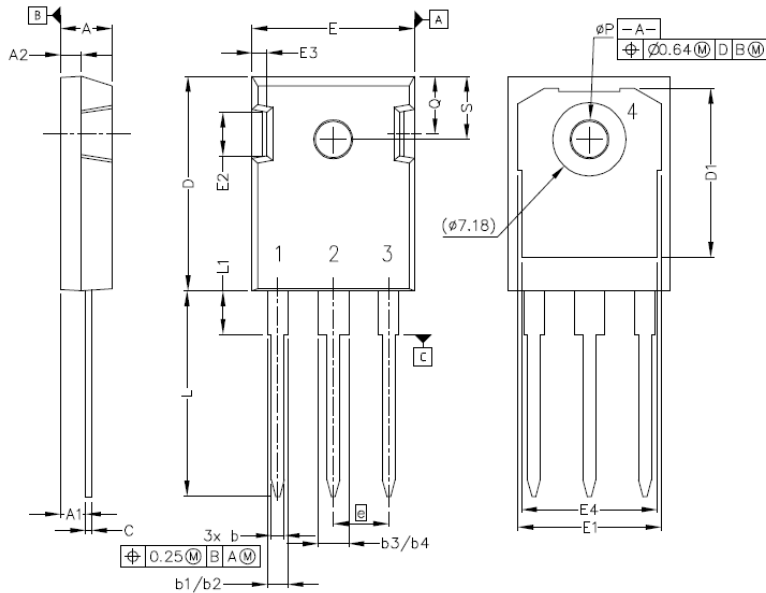


Figure 29. Clamped Inductive Switching Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.

## **Package Dimensions**

Package TO-247-3

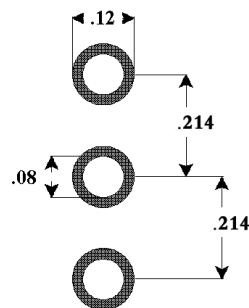


Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

| POS | Inches   |      | Millimeters |       |
|-----|----------|------|-------------|-------|
|     | Min      | Max  | Min         | Max   |
| A   | .190     | .205 | 4.83        | 5.21  |
| A1  | .090     | .100 | 2.29        | 2.54  |
| A2  | .075     | .085 | 1.91        | 2.16  |
| b   | .042     | .052 | 1.07        | 1.33  |
| b1  | .075     | .095 | 1.91        | 2.41  |
| b2  | .075     | .085 | 1.91        | 2.16  |
| b3  | .113     | .133 | 2.87        | 3.38  |
| b4  | .113     | .123 | 2.87        | 3.13  |
| c   | .022     | .027 | 0.55        | 0.68  |
| D   | .819     | .831 | 20.80       | 21.10 |
| D1  | .640     | .695 | 16.25       | 17.65 |
| D2  | .037     | .049 | 0.95        | 1.25  |
| E   | .620     | .635 | 15.75       | 16.13 |
| E1  | .516     | .557 | 13.10       | 14.15 |
| E2  | .145     | .201 | 3.68        | 5.10  |
| E3  | .039     | .075 | 1.00        | 1.90  |
| E4  | .487     | .529 | 12.38       | 13.43 |
| e   | .214 BSC |      | 5.44 BSC    |       |
| N   | 3        |      | 3           |       |
| L   | .780     | .800 | 19.81       | 20.32 |
| L1  | .161     | .173 | 4.10        | 4.40  |
| ØP  | .138     | .144 | 3.51        | 3.65  |
| Q   | .216     | .236 | 5.49        | 6.00  |
| S   | .238     | .248 | 6.04        | 6.30  |
| T   | 9°       | 11°  | 9°          | 11°   |
| U   | 9°       | 11°  | 9°          | 11°   |
| V   | 2°       | 8°   | 2°          | 8°    |
| W   | 2°       | 8°   | 2°          | 8°    |

## **Recommended Solder Pad Layout**



TO-247-3

## Notes

---

- **RoHS Compliance**  
The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of [www.cree.com](http://www.cree.com).
- **REACH Compliance**  
REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.
- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

## Related Links

---

- **C2M PSPIICE Models:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Isolated Gate Driver reference design:** <http://wolfspeed.com/power/tools-and-support>
- **SiC MOSFET Evaluation Board:** <http://wolfspeed.com/power/tools-and-support>

## Данный компонент на территории Российской Федерации

**Вы можете приобрести в компании MosChip.**

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

### Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: [info@moschip.ru](mailto:info@moschip.ru)

Skype отдела продаж:

moschip.ru

moschip.ru\_4

moschip.ru\_6

moschip.ru\_9